# **74ABT841**

# 10-bit bus interface latch; 3-state

Rev. 03 — 25 March 2010

**Product data sheet** 

### 1. General description

The 74ABT841 high performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT841 bus interface register is designed to provide extra data width for wider data/address paths of buses carrying parity.

The 74ABT841 consists of ten D-type latches with 3-state outputs. The flip-flops appear transparent to the data when latch enable (LE) is HIGH. This allows asynchronous operation, as the output transition follows the data in transition. On the LE HIGH-to-LOW transition, the data that meets the set-up and hold time is latched.

Data appears on the bus when the output enable  $(\overline{OE})$  is LOW. When  $\overline{OE}$  is HIGH the output is in the high-impedance state.

### 2. Features and benefits

- High speed parallel latches
- Extra data width for wide address/data paths or buses carrying parity
- Ideal where high speed, light loading, or increased fan-in are required with MOS microprocessors
- Broadside pinout
- Output capability: +64 mA and -32 mA
- Power-up 3-state
- Power-up reset
- Latch-up protection exceeds 500 mA per JESD78B class II level A
- ESD protection:
  - ◆ HBM JESD22-A114F exceeds 2000 V
  - MM JESD22-A115-A exceeds 200 V



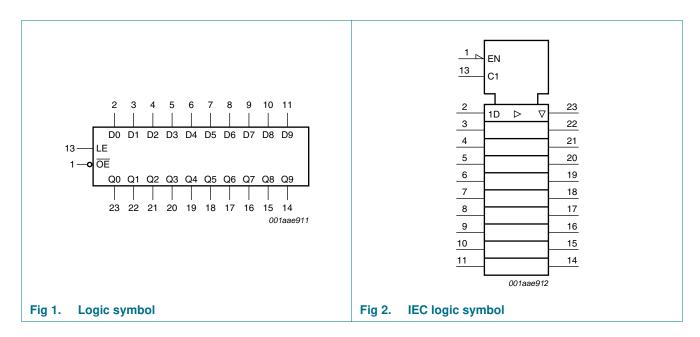
### 10-bit bus interface latch; 3-state

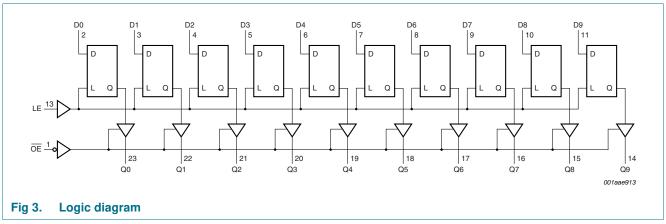
# 3. Ordering information

Table 1. Ordering information

Type number	Package									
	Temperature range	Name	Description	Version						
74ABT841D	-40 °C to +85 °C	SO24	plastic small outline package; 24 leads; body width 7.5 mm	SOT137-1						
74ABT841DB	–40 °C to +85 °C	SSOP24	plastic shrink small outline package; 24 leads; body width 5.3 mm	SOT340-1						
74ABT841PW	–40 °C to +85 °C	TSSOP24	plastic thin shrink small outline package; 24 leads; body width 4.4 mm	SOT355-1						

# 4. Functional diagram

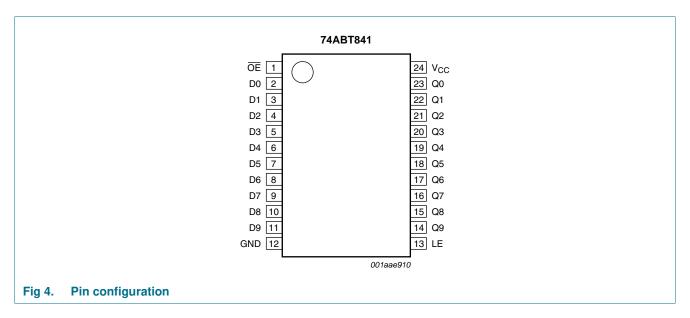




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# 5. Pinning information

### 5.1 Pinning



### 5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
ŌĒ	1	output enable input (active LOW)
D0 to D9	2, 3, 4, 5, 6, 7, 8, 9,10, 11	data input
GND	12	ground (0 V)
LE	13	latch enable input (active falling edge)
Q0 to Q9	23, 22, 21, 20, 19, 18, 17, 16, 15, 14	data output
V <sub>CC</sub>	24	positive supply voltage

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## 6. Functional description

Table 3. Function table[1]

Input			Output	Operating mode
OE	LE	nD	Q0 to Q9	
L	Н	L	L	transparent
L	Н	Н	Н	
L	$\downarrow$	I	L	latched
L	$\downarrow$	h	Н	
Н	Χ	X	Z	high-impedance
L	L	X	NC	hold

<sup>[1]</sup> H = HIGH voltage level;

h = HIGH voltage level one set-up time prior to the LOW-to-HIGH LE transition;

I = LOW voltage level one set-up time prior to the LOW-to-HIGH LE transition;

NC = no change;

X = don't care;

Z = high-impedance OFF-state.

## 7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC}$	supply voltage		-0.5	+7.0	V
V <sub>I</sub>	input voltage		<u>[1]</u> –1.2	+7.0	V
V <sub>O</sub>	output voltage	output in OFF-state or HIGH-state	<u>[1]</u> –0.5	+5.5	V
$I_{IK}$	input clamping current	$V_1 < 0 V$	-18	-	mA
$I_{OK}$	output clamping current	V <sub>O</sub> < 0 V	-50	-	mA
Io	output current	output in LOW-state	-	128	mA
T <sub>j</sub>	junction temperature		[2] _	150	°C
$T_{stg}$	storage temperature		-65	+150	°C

<sup>[1]</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

L = LOW voltage level;

<sup>↓ =</sup> HIGH-to-LOW clock transition;

<sup>[2]</sup> The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C.

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# 8. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CC}$	supply voltage		4.5	-	5.5	V
VI	input voltage		0	-	$V_{CC}$	V
V <sub>IH</sub>	HIGH-level input voltage		2.0	-	-	V
V <sub>IL</sub>	LOW-level input voltage		-	-	0.8	V
I <sub>OH</sub>	HIGH-level output current		-32	-	-	mA
I <sub>OL</sub>	LOW-level output current		-	-	64	mA
$\Delta t/\Delta V$	input transition rise and fall rate		0	-	5	ns/V
T <sub>amb</sub>	ambient temperature	in free air	-40	-	+85	°C

## 9. Static characteristics

Table 6. Static characteristics

Symbol	Parameter	Conditions			25 °C		–40 °C t	o +85 °C	Unit
				Min	Тур	Max	Min	Max	
$V_{IK}$	input clamping voltage	$V_{CC} = 4.5 \text{ V}; I_{IK} = -18 \text{ mA}$	'	-1.2	-0.9	-	-1.2	-	V
V <sub>OH</sub>	HIGH-level output	$V_I = V_{IL}$ or $V_{IH}$							
	voltage	$V_{CC} = 4.5 \text{ V}; I_{OH} = -3 \text{ mA}$		2.5	3.5	-	2.5	-	V
		$V_{CC} = 5.0 \text{ V}; I_{OH} = -3 \text{ mA}$		3.0	4.0	-	3.0	-	V
		$V_{CC} = 4.5 \text{ V}; I_{OH} = -32 \text{ mA}$		2.0	2.6	-	2.0	-	V
V <sub>OL</sub>	LOW-level output voltage	$V_{CC}$ = 4.5 V; $I_{OL}$ = 64 mA; $V_I$ = $V_{IL}$ or $V_{IH}$		-	0.42	0.55	-	0.55	V
V <sub>OL(pu)</sub>	power-up LOW-level output voltage	$V_{CC}$ = 5.5 V; $I_O$ = 1 mA; $V_I$ = GND or $V_{CC}$	[1]	-	0.13	0.55	-	0.55	V
I <sub>I</sub>	input leakage current	$V_{CC} = 5.5 \text{ V}; V_{I} = \text{GND or } 5.5 \text{ V}$							
		control pins		-	±0.01	±1.0	-	±1.0	μА
		data pins		-	±5	±100	-	±100	μА
I <sub>OFF</sub>	power-off leakage current	$V_{CC}$ = 0 V; $V_{I}$ or $V_{O} \leq 4.5 \ V$		-	±5.0	±100	-	±100	μΑ
I <sub>O(pu/pd)</sub>	power-up/power-down output current	$V_{CC}$ = 2.0 V; $V_O$ = $0.5$ V; $V_I$ = GND or $V_{CC}$ ; $\overline{OE}$ n HIGH	[2]	-	±5.0	±50	-	±50	μΑ
l <sub>OZ</sub>	OFF-state output current	$V_{CC} = 5.5 \text{ V}; V_I = V_{IL} \text{ or } V_{IH}$							
		V <sub>O</sub> = 2.7 V		-	5.0	50	-	50	μА
		V <sub>O</sub> = 0.5 V		-	-5.0	-50	-	-50	μА
I <sub>LO</sub>	output leakage current	HIGH-state; $V_O = 5.5 \text{ V}$ ; $V_{CC} = 5.5 \text{ V}$ ; $V_I = \text{GND or } V_{CC}$		-	5.0	50	-	50	μΑ
lo	output current	$V_{CC} = 5.5 \text{ V}; V_{O} = 2.5 \text{ V}$	[3]	-180	-100	-50	-180	-50	mA

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Table 6. Static characteristics ... continued

Symbol	Parameter	Conditions			25 °C		–40 °C to	o +85 °C	Unit
				Min	Тур	Max	Min	Max	
$I_{CC}$	supply current	$V_{CC}$ = 5.5 V; $V_{I}$ = GND or $V_{CC}$							
		outputs HIGH-state		-	0.5	250	-	250	μΑ
		outputs LOW-state		-	25	38	-	38	mA
		outputs disabled		-	0.5	250	-	250	μΑ
$\Delta I_{CC}$	additional supply current	per input pin; $V_{CC}$ = 5.5 V; one input at 3.4 V; other inputs at $V_{CC}$ or GND	<u>[4]</u>	-	0.5	1.5	-	1.5	mA
Cı	input capacitance	$V_I = 0 \text{ V or } V_{CC}$		-	4	-	-	-	pF
Co	output capacitance	outputs disabled; $V_O = 0 \text{ V or } V_{CC}$		-	7	-	-	-	pF

<sup>[1]</sup> For valid test results, data must not be loaded into the flip-flops (or latches) after applying the power.

## 10. Dynamic characteristics

**Table 7. Dynamic characteristics** GND = 0 *V; for test circuit, see Figure 9*.

Symbol	Parameter	Conditions		25 °C; V <sub>CC</sub> = 5.0 V			-40 °C to +70 °C; V <sub>CC</sub> = 5.0 V $\pm$ 0.5 V		
			Min	Тур	Max	Min	Max		
$t_{PLH}$	LOW to HIGH	Dn to Qn; see Figure 5	2.1	4.1	5.5	2.1	6.2	ns	
	propagation delay	LE to Qn; see Figure 6	2.1	4.1	5.9	2.1	6.5	ns	
t <sub>PHL</sub>	HIGH to LOW	Dn to Qn; see Figure 5	2.0	4.0	5.5	2.0	6.2	ns	
	propagation delay	LE to Qn; see Figure 6	2.8	4.6	6.2	2.8	6.7	ns	
t <sub>PZH</sub>	OFF-state to HIGH propagation delay	OE to Qn; see Figure 7	1.0	3.0	4.5	1.0	5.3	ns	
t <sub>PZL</sub>	OFF-state to LOW propagation delay	OE to Qn; see Figure 7	2.2	4.1	5.6	2.2	6.3	ns	
t <sub>PHZ</sub>	HIGH to OFF-state propagation delay	OE to Qn; see Figure 7	2.7	4.7	6.2	2.7	7.1	ns	
t <sub>PLZ</sub>	LOW to OFF-state propagation delay	OE to Qn; see Figure 7	2.8	4.6	6.1	2.8	6.5	ns	
t <sub>su(H)</sub>	set-up time HIGH	Dn to LE; see Figure 8	2.5	1.0	-	2.5	-	ns	
t <sub>su(L)</sub>	set-up time LOW	Dn to LE; see Figure 8	1.5	0	-	1.5	-	ns	
t <sub>h(H)</sub>	hold time HIGH	Dn to LE; see Figure 8	1.5	0.2	-	1.5	-	ns	
t <sub>h(L)</sub>	hold time LOW	Dn to LE; see Figure 8	+1.0	-0.8	-	1.0	-	ns	
t <sub>WH</sub>	pulse width HIGH	LE; see Figure 6	3.3	1.9	-	3.3	-	ns	
$t_{WL}$	pulse width LOW	LE; see Figure 6	3.3	1.9	-	3.3	-	ns	

<sup>[2]</sup> This parameter is valid for any  $V_{CC}$  between 0 V and 2.1 V with a transition time of up to 10 ms. For  $V_{CC}$  = 2.1 V to  $V_{CC}$  = 5 V  $\pm$  10 %, a transition time of up to 100  $\mu$ s is permitted.

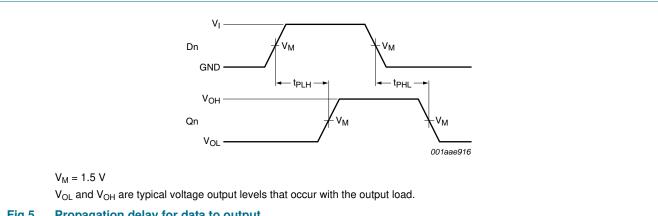
<sup>[3]</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

<sup>[4]</sup> This is the increase in supply current for each input at 3.4 V.

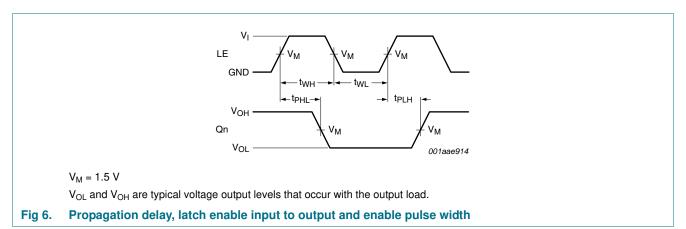
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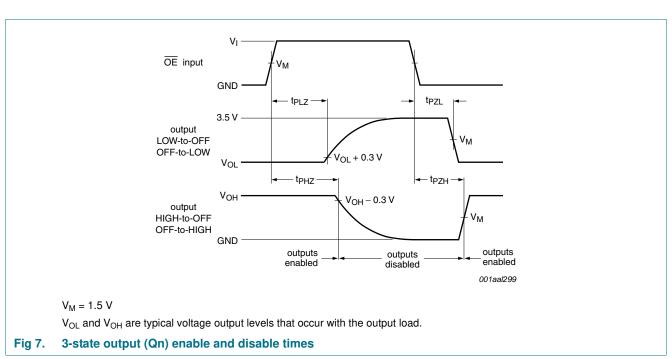
10-bit bus interface latch; 3-state

### 11. Waveforms



Propagation delay for data to output Fig 5.

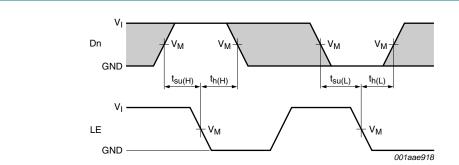




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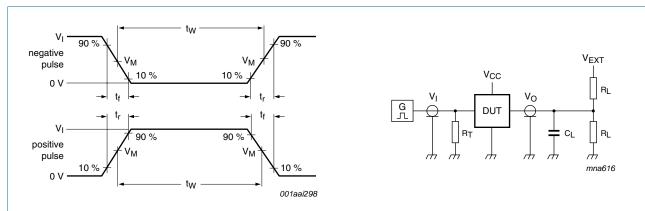
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 $V_{M} = 1.5 V$ 

The shaded areas indicate when the input is permitted to change for predictable output performance.

Fig 8. Data set-up and hold times



b. Test circuit

a. Input pulse definition

Test data and V<sub>EXT</sub> levels are given in Table 8.

R<sub>L</sub> = Load resistance.

C<sub>L</sub> = Load capacitance including jig and probe capacitance.

 $R_T$  = Termination resistance should be equal to output impedance  $Z_o$  of the pulse generator.

 $V_{\text{EXT}}$  = Test voltage for switching times.

Fig 9. Test circuit for measuring switching times

Table 8. Test data

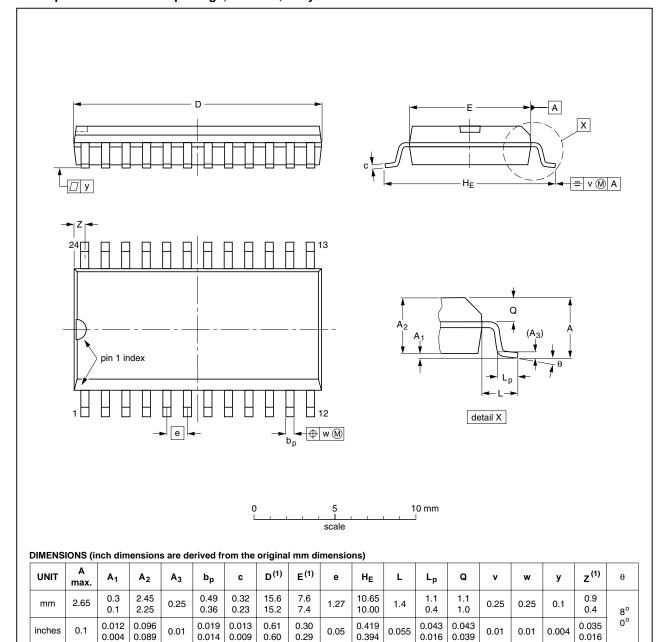
Input				Load		V <sub>EXT</sub>			
VI	f <sub>l</sub>	t <sub>W</sub>	t <sub>r</sub> , t <sub>f</sub>	CL	R <sub>L</sub>	t <sub>PHL</sub> , t <sub>PLH</sub>	t <sub>PZH</sub> , t <sub>PHZ</sub>	$t_{PZL}$ , $t_{PLZ}$	
3.0 V	1 MHz	500 ns	$\leq$ 2.5 ns	50 pF	$500 \Omega$	open	open	7.0 V	

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## 12. Package outline

### SO24: plastic small outline package; 24 leads; body width 7.5 mm

SOT137-1



#### Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE	OUTLINE REFERENCES		EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA		PROJECTION	155UE DATE	
SOT137-1	075E05	MS-013				<del>99-12-27</del> 03-02-19	

Fig 10. Package outline SOT137-1 (SO24)

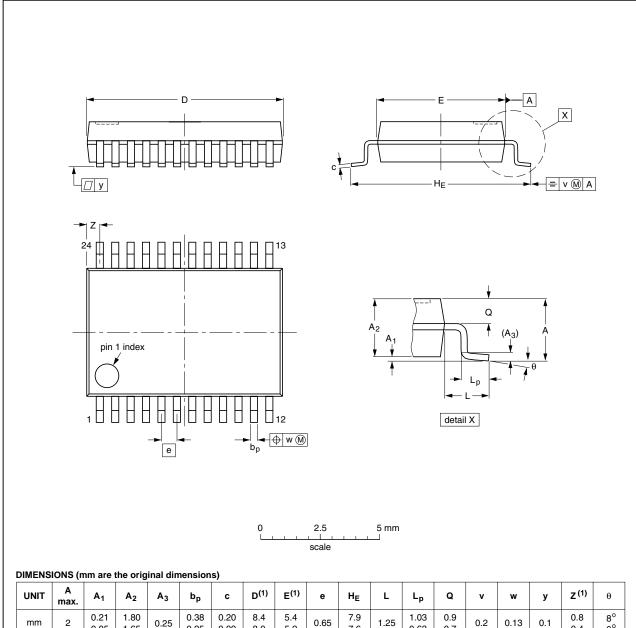
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SSOP24: plastic shrink small outline package; 24 leads; body width 5.3 mm

SOT340-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(1)</sup>	e	HE	L	Lp	Q	٧	w	у	Z <sup>(1)</sup>	θ
mm	2	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	8.4 8.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	0.8 0.4	8° 0°

#### Note

1. Plastic or metal protrusions of 0.2 mm maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC JEITA		PROJECTION	ISSUE DATE
SOT340-1		MO-150			<del>99-12-27</del> 03-02-19

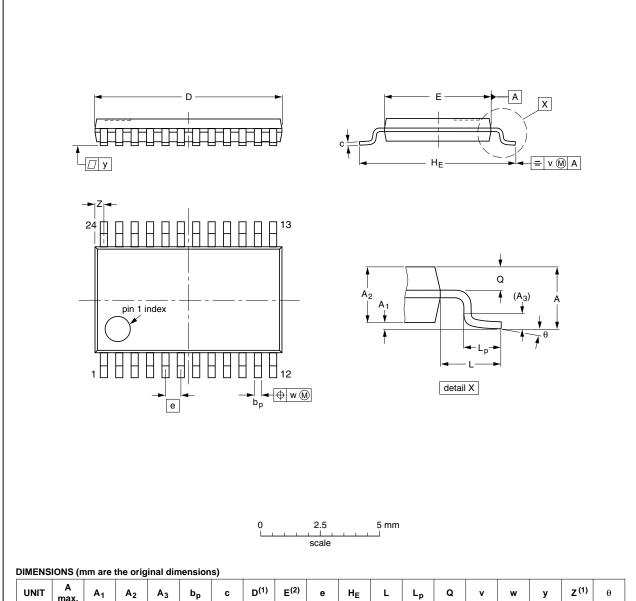
Fig 11. Package outline SOT340-1 (SSOP24)

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TSSOP24: plastic thin shrink small outline package; 24 leads; body width 4.4 mm

SOT355-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	C	D <sup>(1)</sup>	E <sup>(2)</sup>	e	HE	L	Lp	Q	٧	w	у	Z <sup>(1)</sup>	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	7.9 7.7	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.5 0.2	8° 0°

#### Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

JEDEC	JEITA		PROJECTION	ISSUE DATE	
				ISSUE DATE	
MO-153				<del>99-12-27</del> 03-02-19	
1	MO-153	MO-153	MO-153	MO-153	

Fig 12. Package outline SOT355-1 (TSSOP24)

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## 13. Abbreviations

### Table 9. Abbreviations

Acronym	Description
BiCMOS	Bipolar Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model

# 14. Revision history

### Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes				
74ABT841_3	20100325	Product data sheet	-	74ABT841_2				
74ABT841_2	20100302	Product data sheet	-	74ABT841				
Modifications:	<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> </ul>							
	<ul> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul>							
	<ul> <li>DIP 24 (SOT222-1) package removed from <u>Section 3 "Ordering information"</u> and <u>Section 12 "Package outline"</u>.</li> </ul>							
74ABT841	19950906	Product specification	-	-				

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### 15. Legal information

#### 15.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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### 10-bit bus interface latch; 3-state

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